L Number Hits Search Text DB Time stam 194 werner-brian\$ 2003/07/2 2003/07/2 4 werner-brian\$ and simulation and resist USPAT 2003/07/2 2003/07/2 26 ("4628531" "4633504" "4641353" USPAT 2003/07/2	4 09:24 4 10:17 4 09:24
2	24 10:17 24 09:24
3	24 09:24
"4669123" "4958374" "5023328" "5293557" "5307421" "5475766" "5481624" "5513275" "5572598" "5582939" "5621652" "5633713" "5736280" "5745388" "5801954" "5804340" "5849440" "5889678" "6067375" "6081659").PN. 4	
"5293557" "5307421" "5475766" "5481624" "5513275" "5572598" "5582939" "5621652" "5633713" "5736280" "5745388" "5801954" "5804340" "5849440" "5889678" "5889686" "5965306" "6014456" "6067375" "6081659").PN. 4	
"5481624" "5513275" "5572598" "5582939" "5621652" "5633713" "5736280" "5745388" "5801954" "5804340" "5849440" "5889678" "5889686" "5965306" "6014456" "6067375" "6081659").PN. 4	
"5582939" "5621652" "5633713" "5736280" "5745388" "5801954" "5804340" "5849440" "5889678" "5889686" "5965306" "6014456" "6067375" "6081659").PN. 4	
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"5804340"	
"5889686" "5965306" "6014456" USPAT 2003/07/2 6067375" "6081659").PN. 1 6272236.URPN. 5 6091845.URPN. 6091845.URPN. 1516 (382/141-151).CCLS. 7 0 ("6 and display\$5 with superimpos\$5 with USPAT 2003/07/2 image").PN.	
"6067375" "6081659").PN. USPAT 2003/07/2 200	
4 1 6272236.URPN. USPAT 2003/07/2 2003/07/2 2003/07/2 2003/07/2 2003/07/2 2003/07/2 2003/07/2 2003/07/2 2003/07/2 2003/07/2 2003/07/2 2003/07/2 2003/07/2 2003/07/2 2003/07/2 2003/07/2	
5 6091845.URPN. USPAT 2003/07/2 20	
6 1516 (382/141-151).CCLS. USPAT 2003/07/2 ("6 and display\$5 with superimpos\$5 with USPAT 2003/07/2 image").PN.	
7 0 ("6 and display\$5 with superimpos\$5 with 'USPAT 2003/07/2 image").PN.	
image").PN.	
	4 10:18
0	
	4 10:18
(overlap\$5 or superimpos\$5) near image	
15 16 wafer same (superimpos\$5) same width same USPAT 2003/07/2	4 10:28
area	
6 wafer and display\$5 near (superimpos\$5) and USPAT 2003/07/2	4 11:05
width same area	= =
0 analyze near defects same (area and width) USPAT 2003/07/2	4 11:06
20 1243 (analyze or analysis or characteriz\$5) near USPAT 2003/07/2	
defects	
21 1243 (analyze or analysis or characteriz\$5) near USPAT 2003/07/2	4 11.07
defect	1 11.07
23 1 ((analyze or analysis or characteriz\$5) near USPAT 2003/07/2	4 11.07
defect) same (line near width) same area	4 11:07
	4 12 21
22 26 ((analyze or analysis or characteriz\$5) near USPAT 2003/07/2 defect) and (line near width) same area	4 13:21
	4 12 22
1 1	4 13:23
difference	
25 250 percentage with area with difference USPAT 2003/07/2	
0 (percentage with area with difference) and USPAT 2003/07/2	4 13:24
inspectionwafer	
9 (percentage with area with difference) and USPAT 2003/07/2	4 13:24
wafer	
28 19 (percentage with area with difference) and USPAT 2003/07/2	4 13:25
inspection	
29 0 ("6 and (percent%5 or "%") with difference USPAT 2003/07/2	4 13:26
with area").PN.	
30 0 ((382/141-151).CCLS.) and (percent%5 or "%") USPAT 2003/07/2	4 13:27
with difference with area	
31 8 ((382/141-151).CCLS.) and (percent%5 or "%") USPAT 2003/07/2	4 13:28
with area	
32 9 (percent%5 or "%") near difference with area USPAT 2003/07/2	
0 (percent%5 or "%") near difference with USPAT 2003/07/2	
overall near area	
34 32 (percent%5 or "%") near difference same area USPAT 2003/07/2	4 13:35
35 23 ((percent%5 or "%") near difference same USPAT 2003/07/2	
area) not ((percent%5 or "%") near	
difference with area)	
36 2 (percent%5 or "%") near difference with USPAT 2003/07/2	4 13:36
defect	
37 98 (percent\$5 or "%") near difference with area USPAT 2003/07/2	4 13:38
38 2 ((percent\$5 or "%") near difference with USPAT 2003/07/2	
area) same defect	3.3,
39 5 ((percent\$5 or "%") near difference with USPAT 2003/07/2	4 13.37
area) and inspect\$5	- +3.37
40 0 (percent\$5 or "%") near difference with USPAT 2003/07/2	4 13.30
(overlap\$5 or superimpos\$5) near area	- +5.50
42 848193 area near ratio with (template or USPAT 2003/07/2	4 13.30
reference) t	ב בינד ב
43 23 (area near ratio with defect) and (area near USPAT 2003/07/2	4 12.40
ratio with (template or reference)t)	- 13:4U
	4 12 40
	4 13:40
ratio with (template or reference)) 41 41 area near ratio with defect USPAT 2003/07/2	4 12
46 0 area with percent \$5 with defect USPAT 2003/07/2	

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47	133	area with percent\$5 with defect	USPAT	2003/07/24 13:47
48	47	(area with percent\$5 with defect) and image	USPAT	2003/07/24 13:47
-		werner-brian\$	USPAT	2003/07/24 09:24
-	29	werner-brian\$ and simulat\$6	USPAT	2003/07/23 15:55
-	1	("6091845").PN.	USPAT	2003/07/23 15:55

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